IAPIORec'd PCT/PTO (12 DEC 2005)



PATENT 8075-1015

IN THE U.S. PATENT AND TRADEMARK OFFICE

In re application of

Rikizo HATAKEYAMA et al.

Application No. 10/552,709

Filed October 7, 2005

METHOD AND APPARATUS FOR PRODUCING GAS ATOM CONTAINING FULLERENE, AND GAS ATOM CONTAINING FULLERENE

INFORMATION DISCLOSURE STATEMENT

Assistant Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

December 2, 2005

Sir:

In compliance with Rules 1.97 and 1.98, and in fulfillment of the duty of disclosure under Rule 1.56, the accompanying document, copy of which is attached to this statement, is made of record on the enclosed Form PTO-1449.

A concise explanation of the relevance of this item is that this reference was discovered during any searches they or their client had made, or that they were considered in the preparation of the application.

Respectfully submitted,

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(Use several sheets if necessary)			Filing Date: October 7, 2005		Group Art Unit:		
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	Akihiko FUJII et al., "Ph Endohedral Metallofulle 2255.	otocurrent Enhan rene La@C ₈₂ ," Jp	ncement in Conducting Pon. J. Appl. Phys., Vol. 41	olymer Devi	ice by Dopin 4A, (2002),	ng with pp. 2254-	
							
EXAMINER	•		DATE CONSIDERED				

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP § 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to the applicant.

^{*} Abstract provided for the Examiner's convenience